

January 2011 SupreMOSTM

FCH47N60NF

N-Channel MOSFET, FRFET 600V, 47A, $65m\Omega$

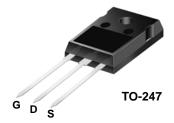
Features

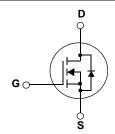
- $R_{DS(on)} = 57.5 \text{m}\Omega \text{ (Typ.)}$ @ $V_{GS} = 10 \text{V}$, $I_D = 23.5 \text{A}$
- Ultra Low Gate Charge (Typ. Q_g = 121nC)
- Low Effective Output Capacitance
- 100% Avalanche Tested
- · RoHS Compliant

Description

The SupreMOS MOSFET, Fairchild's next generation of high voltage super-junction MOSFETs, employs a deep trench filling process that differentiates it from preceding multi-epi based technologies. By utilizing this advanced technology and precise process control, SupreMOS provides world class Rsp, superior switching performance and ruggedness.

This SupreMOS MOSFET fits the industry's AC-DC SMPS requirements for PFC, server/telecom power, FPD TV power, ATX power, and industrial power applications.





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

| Symbol | | Parameter | | Ratings | Units |
|-----------------------------------|--|--------------------------------------|----------|-------------|-------|
| V _{DSS} | Drain to Source Voltage | | | 600 | V |
| V _{GSS} | Gate to Source Voltage | | | ±30 | V |
| 1 | Drain Current | -Continuous (T _C = 25°C) | | 45.8 | ۸ |
| I _D | Drain Current | -Continuous (T _C = 100°C) | | 28.9 | A |
| I_{DM} | Drain Current | - Pulsed | (Note 1) | 137.4 | Α |
| E _{AS} | Single Pulsed Avalanche Energy (Note 2) | | | 2926 | mJ |
| I _{AR} | Avalanche Current | | | 15.3 | Α |
| E _{AR} | Repetitive Avalanche Ene | Repetitive Avalanche Energy | | | mJ |
| du/dt | MOSFET dv/dt Ruggedne | ess | | 100 | V/ns |
| dv/dt | Peak Diode Recovery dv/d | dt | (Note 3) | 50 | V/ns |
| D | Dower Dissipation | $(T_C = 25^{\circ}C)$ | | 368 | W |
| P_{D} | Power Dissipation | - Derate above 25°C | | 2.94 | W/°C |
| T _J , T _{STG} | Operating and Storage Te | mperature Range | | -55 to +150 | °C |
| T _L | Maximum Lead Temperate 1/8" from Case for 5 Seco | • • | | 300 | °C |

^{*}Drain current limited by maximum junction temperature

Thermal Characteristics

| Symbol | Parameter | Ratings | Units |
|-----------------|---|---------|-------|
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case | 0.34 | |
| $R_{\theta CS}$ | Thermal Resistance, Case to Heat Sink (Typical) | 0.24 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction to Ambient | 40 | |

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|------------|---------|-----------|------------|----------|
| FCH47N60NF | FCH47N60NF | TO-247 | = | - | 30 |

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Units |
|--------------------------------------|--|---|------|------|------|-------|
| Off Charac | cteristics | | | | | |
| BV _{DSS} | Drain to Source Breakdown Voltage | $I_D = 1 \text{mA}, V_{GS} = 0 \text{V}, T_C = 25^{\circ} \text{C}$ | 600 | - | - | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | I _D = 1mA, Referenced to 25°C | - | 0.78 | - | V/°C |
| 1 | Zoro Coto Voltago Proin Current | $V_{DS} = 480V, V_{GS} = 0V$ | - | - | 10 | ^ |
| IDSS | Zero Gate Voltage Drain Current | $V_{DS} = 480V, V_{GS} = 0V, T_{C} = 125^{\circ}C$ - | | - | 100 | μА |
| I _{GSS} | Gate to Body Leakage Current | $V_{GS} = \pm 30V, V_{DS} = 0V$ | - | - | ±100 | nA |

On Characteristics

| V _{GS(th)} | Gate Threshold Voltage | $V_{GS} = V_{DS}$, $I_D = 250\mu A$ | 2 | - | 4 | V |
|---------------------|--------------------------------------|--------------------------------------|---|------|------|----|
| R _{DS(on)} | Static Drain to Source On Resistance | $V_{GS} = 10V, I_D = 23.5A$ | • | 57.5 | 65.0 | mΩ |
| g _{FS} | Forward Transconductance | $V_{DS} = 40V, I_{D} = 23.5A$ | - | 52 | 100 | S |

Dynamic Characteristics

| C _{iss} | Input Capacitance | V 400V V 0V | - | 4600 | 6120 | pF |
|------------------|-----------------------------------|--|---|------|------|----|
| C _{oss} | Output Capacitance | $V_{DS} = 100V, V_{GS} = 0V$ f = 1MHz | | 195 | 260 | pF |
| C _{rss} | Reverse Transfer Capacitance | 1 - 1101112 | - | 3.0 | 5.0 | pF |
| C _{oss} | Output Capacitance | $V_{DS} = 380V, V_{GS} = 0V, f = 1MHz$ | - | 108 | - | pF |
| Cosseff. | Effective Output Capacitance | $V_{DS} = 0V$ to 380V, $V_{GS} = 0V$ | - | 492 | - | pF |
| $Q_{g(tot)}$ | Total Gate Charge at 10V | | - | 121 | 157 | nC |
| Q_{gs} | Gate to Source Gate Charge | $V_{DS} = 380V, I_{D} = 23.5A,$ | - | 23 | - | nC |
| Q_{gd} | Gate to Drain "Miller" Charge | V _{GS} = 10V (Note 4) | - | 47 | - | nC |
| ESR | Equivalent Series Resistance(G-S) | Drain Open | - | 0.9 | - | Ω |

Switching Characteristics

| t _{d(on)} | Turn-On Delay Time | | | 34 | 78 | ns |
|---------------------|---------------------|------------------------------|---|-----|-----|----|
| t _r | | $V_{DD} = 380V, I_D = 23.5A$ | - | 22 | 54 | ns |
| t _{d(off)} | Turn-Off Delay Time | $R_{GEN} = 4.7\Omega$ | - | 117 | 244 | ns |
| t _f | Turn-Off Fall Time | (Note 4) | - | 4 | 18 | ns |

Drain-Source Diode Characteristics

| I _S | Maximum Continuous Drain to Source Diode Forward Current | | | - | 47 | Α |
|-----------------|---|-------------------------------|---|-----|-----|----|
| I _{SM} | Maximum Pulsed Drain to Source Diode Forward Current | | | - | 141 | Α |
| V_{SD} | Drain to Source Diode Forward Voltage V _{GS} = 0V, I _{SD} = 23.5A | | - | - | 1.2 | V |
| t _{rr} | Reverse Recovery Time | $V_{GS} = 0V, I_{SD} = 23.5A$ | - | 169 | - | ns |
| Q_{rr} | Reverse Recovery Charge | $dI_F/dt = 100A/\mu s$ | - | 1.3 | - | μС |

Notes

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. I_{AS} = 15.3A, R_G = 25 Ω , Starting T_J = 25 $^{\circ}C$
- 3. I $_{SD} \le 45.8$ A, di/dt ≤ 1200 A/ μ s, V $_{DD} \le 380$ V, Starting T $_{J}$ = 25° C
- 4. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

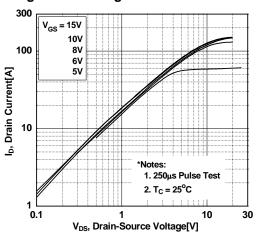


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

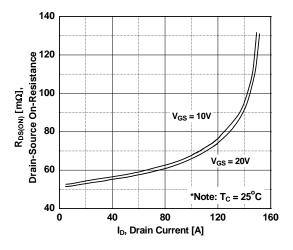


Figure 5. Capacitance Characteristics

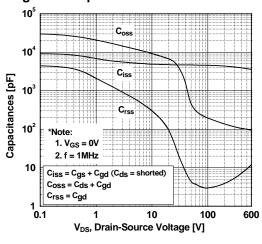


Figure 2. Transfer Characteristics

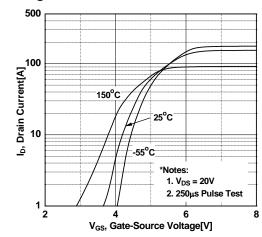


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

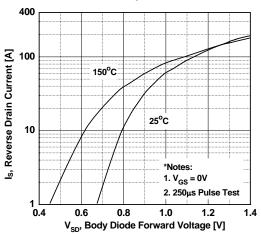
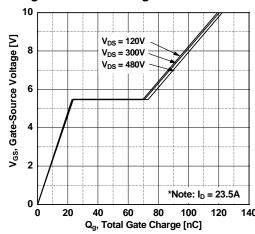


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

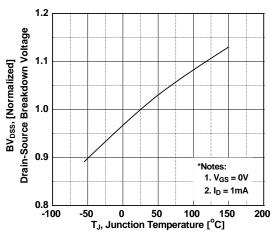


Figure 9. Maximum Safe Operating Area

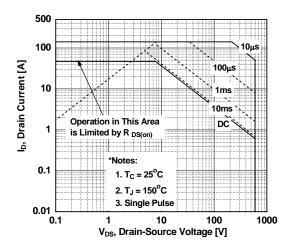


Figure 8. On-Resistance Variation vs. Temperature

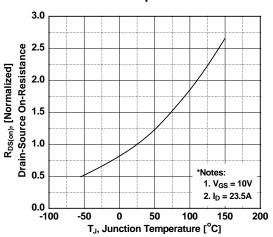


Figure 10. Maximum Drain Current vs. Case Temperature

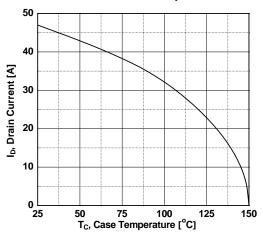
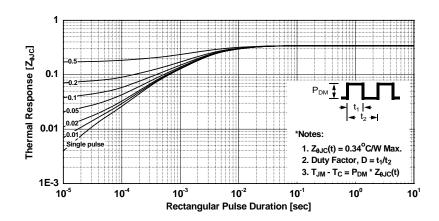
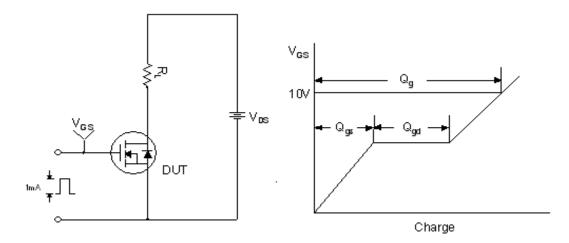


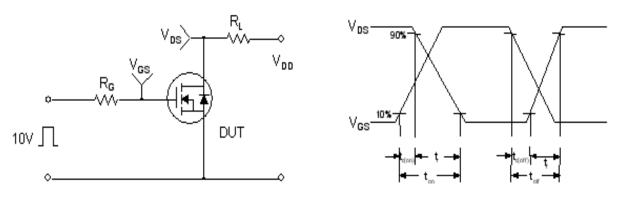
Figure 11. Transient Thermal Response Curve



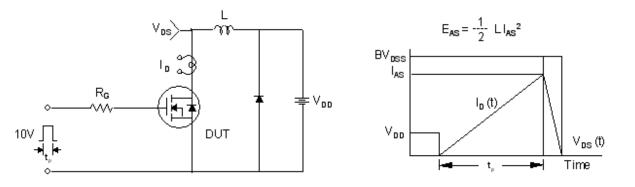
Gate Charge Test Circuit & Waveform



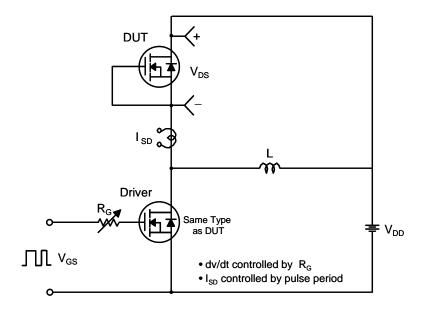
Resistive Switching Test Circuit & Waveforms

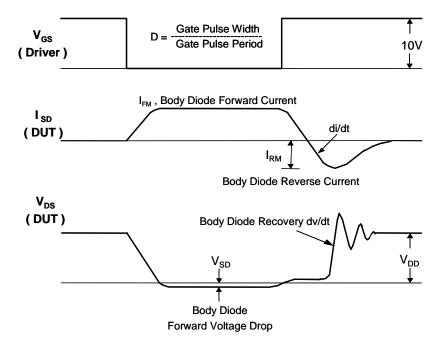


Unclamped Inductive Switching Test Circuit & Waveforms



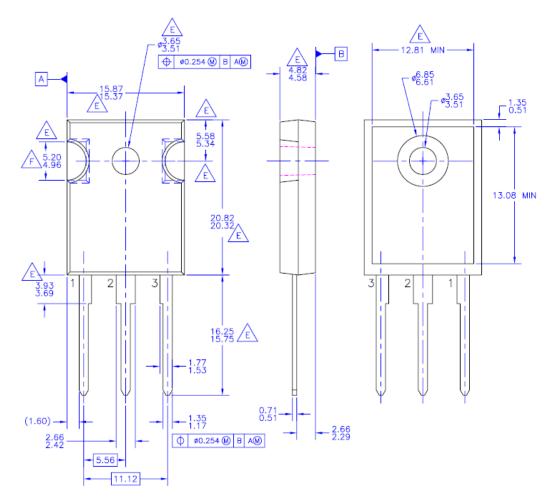
Peak Diode Recovery dv/dt Test Circuit & Waveforms





Mechanical Dimensions

TO-247-3L



NOTES; UNLESS OTHERWISE SPECIFIED

- A. PACKAGE REFERENCE: JEDEC TO-247, ISSUE E, VARIATION AB, DATED JUNE, 2004.
- B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
- C. ALL DIMENSIONS ARE IN MILLIMETERS.
- D. DRAWING CONFORMS TO ASME Y14.5 1994

E DOES NOT COMPLY JEDEC STANDARD VALUE

F. NOTCH MAY BE SQUARE
G. DRAWING FILENAME: MKT-TO247A03_REV02

Dimensions in Millimeters





TRADEMARKS

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

AccuPower™ Auto-SPM™ Build it Now™ CorePLUS™ CorePOWER™ CROSSVOLT™ $\mathsf{CTL}^{\mathsf{TM}}$ Current Transfer Logic™

DEUXPEED® Dual Cool™ EcoSPARK® EfficentMax™ **ESBC™**

Fairchild[®] Fairchild Semiconductor® FACT Quiet Series™ FACT®

 $\mathsf{FAST}^{\mathbb{R}}$ FastvCore™ FETBench™ FlashWriter® *

F-PFS™ FRFET®

Global Power ResourceSM Green FPS™ Green FPS™ e-Series™ Gmax™

GTO™ IntelliMAX™ ISOPLANAR™ MegaBuck™ MIČROCOUPLER™ MicroFET™

MicroPak™ MicroPak2™ MillerDrive™ MotionMax™ Motion-SPM™ OptiHiT™ OPTOLOGIC® OPTOPLANAR®

PDP SPM™ Power-SPM™ PowerTrench® PowerXS™

Programmable Active Droop™

QFĔT® OSTM Quiet Series™ RapidConfigure™

Saving our world, 1mW/W/kW at a time™ SignalWise™ SmartMax™ SMART START™

SPM[®] STEALTH™ SuperFET® SuperSOT™-3 SuperSOT™-6 SuperSOT™-8 SupreMOS® SyncFET™ Sync-Lock™

SYSTEM ®*

The Power Franchise®

The Right Technology for Your Success™

⊍wer franchise TinyBoost™ TinyBuck™ TinyCalc™ TinyLogic[®] TINYOPTO™ TinyPower™ TinyPWM™ TinyWire™ TriFault Detect™ TRUECURRENT™* uSerDes™

UHC® Ultra FRFET™ UniFET™ VCX™ VisualMax™ XSTM

*Trademarks of System General Corporation, used under license by Fairchild Semiconductor.

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

LIFE SUPPORT POLICY FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used here in:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or

ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.Fairchildsemi.com, under Sales Support.

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufactures of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed application, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full traceability, meet Fairchild's quality standards for handing and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address and warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

PRODUCT STATUS DEFINITIONS **Definition of Terms**

| Datasheet Identification Product Status | | Definition |
|---|-----------------------|---|
| Advance Information | Formative / In Design | Datasheet contains the design specifications for product development. Specifications may change in any manner without notice. |
| Preliminary | First Production | Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design. |
| No Identification Needed | Full Production | Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design. |
| Obsolete | Not In Production | Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only. |

Rev. I51